# SN54178, SN74178 4-BIT PARALLEL-ACCESS SHIFT REGISTERS

### **SDLS070**

DECEMBER 1972-REVISED MARCH 1988

- Typical Maximum Clock Frequency . . . 39 MHz
- Three Operating Modes:

Synchronous Parallel Load Right Shift Hold (Do Nothing)

- Negative-Edge-Triggered Clocking
- D-C Coupling Symplifies System Designs

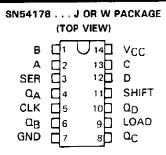
## description

These shift registers utilize fully d-c coupled storage elements and feature synchronous parallel inputs and parallel outputs.

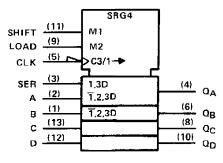
Parallel loading is accomplished by taking the shift input low, applying the four bits of data, and taking the load input high. The data is loaded into the associated flip-flop synchronously and appears at the outputs after a high-to-low transition of the clock. During loading, serial data flow is inhibited.

Shift right is also accomplished on the falling edge of the clock pulse when the shift input is high regardless of the level of the load input. Serial data for this mode is entered at the serial data input.

When both the shift and load inputs are low, clocking of the register can continue; however, data appearing at each output is fed back to the flip-flop input creating a mode in which the data is held unchanged. Thus, the system clock may be left free-running without changing the contents of the register.



## lagic symbol†



<sup>†</sup>This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617.12.

#### **FUNCTION TABLE**

INPUTS							OUTPUTS					
SHIFT	LOAD	СГОСК	SERIAL	PARALLEL				۵.	0-		a <sub>o</sub>	
				Α	8	С	D	QA.	αB	αc	40	
Х	Х	Н	Х	х	Х	Х	Х	QAQ	σ <sub>B0</sub>	₫C0	$\sigma_{D0}$	
L	L	Ţ	х	х	Х	Х	Х	QAO	$\sigma_{BO}$	$a_{C0}$	$\sigma_{D0}$	
L	H	<b>1</b>	X	а	b	c	d	a	b	С	đ	
Н	Х	ı	н	х	Х	Х	Х	н	$\sigma_{An}$	$a_{Bn}$	$\sigma_{Cn}$	
Н	х	1	L	х	Х	Х	Х	Ł	QAn	$\alpha_{Bn}$	$\alpha_{Cn}$	

H = high level (steady state), L = low level (steady state)

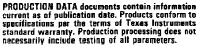
X = irrelevant (any input, including transitions)

1 = transition from high to low level

 $\phi$  = transition from high to low level a, b, c, d = the level of steady-state input at inputs A, B, C, or D, respectively.

QAO, QBO, QCO, QDO = the level of QA, QB, QC, or QD, respectively, before the indicated steady-state input conditions were established.

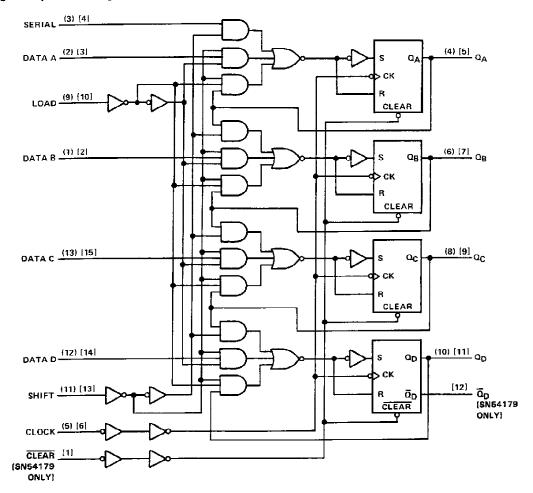
 $Q_{An}$ ,  $Q_{Bn}$ ,  $Q_{Cn}$  = the level of  $Q_{A}$ ,  $Q_{B}$ , or  $Q_{C}$ , respectively, before the most-recent 1 transition of the clock.



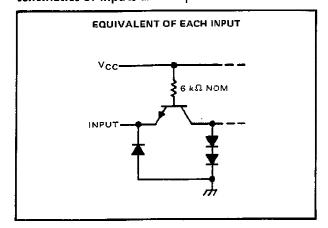


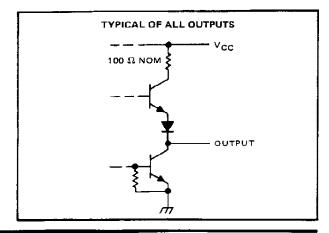
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# logic diagram (positive logic)



## schematics of inputs and outputs







# 

## NOTE 1: Voltage values are with respect to network ground terminal.

## recommended operating conditions

			SN5417	8	SN74178			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, VCC		4.5	5	5.5	4.75	5	5.25	٧
High-level output current, IOH				-800			-800	μА
Low-level output current, IQL				16			16	mA
Clock frequency, fclock				25	0		25	MHz
Width of clock or clear pulse, tw (see	Figure 1)	20			20			ns
	Shift (H or L) or load	35			35			T
Setup time t <sub>su</sub> (see Figure 1)	Data	30			30			กร
Hold time at any input, th		5			5			ns
Operating free-air temperature, TA		- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			SN54178			SN74178			
PARAMETER		TEST CONDITIONS†	MIN	TYP# MAX		MIN	TYP‡	MAX	UNIT
ViH	High-level input voltage		2			2			٧
VIL	Low-level input voltage		1		0.8			8.0	٧
VIK	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA	1		<del>-</del> 1.5		·	-1.5	٧
VOH	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -800 μA	2.4	3.4		2.4	3.4		٧
VOL	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>DL</sub> = 16 mA		0.2	0.4		0.2	0.4	٧
11	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>1</sub> = 5.5 V	1		1			1	mΑ
ЦН	High-level input current	VCC = MAX, VI = 2.4 V	T		40			40	μА
TIL	Low-level input current	VCC = MAX, VI = 0.4 V			1.6			-1.6	mA
los	Short-circuit output current §	V <sub>CC</sub> = MAX	-20		-57	-18		-57	mΑ
<sup>1</sup> CC	Supply current	VCC = MAX, See Note 2		46	70		46	75	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

NOTE 2: I<sub>CC</sub> is measured as follows:

- a) 4.5 V is applied to serial inputs, load, shift, and clear,
- b) Parallel inputs A through D are grounded.
- cl 4.5 V is momentarily applied to clock which is then grounded.

 $<sup>\</sup>ddagger$ All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C.

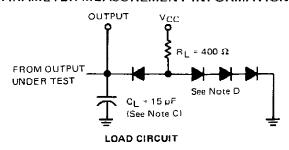
 $<sup>^{\</sup>mbox{\S}}$  Not more than one output should be shorted at a time.

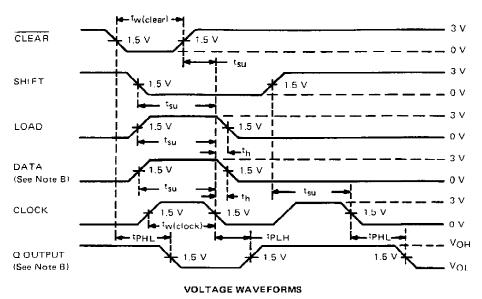
# SN54178, SN74178 **4-BIT PARALLEL-ACCESS SHIFT REGISTERS**

# switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER†	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>max</sub>				25	39		MHz
<sup>t</sup> PLH	Clear	· <u>a</u> D	C 15 ps P 400 ft		15	23	ns
tPHL.	Clear	Ω <sub>A</sub> , Ω <sub>B</sub> , Ω <sub>C</sub> , Ω <sub>D</sub>	$C_L = 15 \text{ pF},  R_L = 400 \Omega,$ See Figure 1		24	36	713
tPLH	Clack	Any output	Sec rigure i		17	26	ns
tPHL		Any output			23	35	"

### PARAMETER MEASUREMENT INFORMATION





- NOTES: A. Input pulses are supplied by generators having the following characteristics:  $t_{TLH} \le 10 \text{ ns}$ ,  $t_{THL} \le 10 \text{ ns}$ ,  $PRR \le 1 \text{ MHz}$ ,  $z_{out} \approx$  50  $\Omega$ .
  - B. Data input and Q output are any related pair. Serial and other data inputs are at GND, Serial data input is tested in conjunction with  $Q_{A}$  output in the shift mode.
  - C. GL includes probe and jiy capacitance.
  - D. All diodes are 1N3064 or equivalent,

FIGURE 1-SWITCHING TIMES



<sup>†</sup>f<sub>max</sub> = Maximum clock frequency tpHL = Propagation delay time, high-to-low-level output

tpLH = Propagation delay time, low-to-high-level output

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